

**Search Notes**

Application/Control No.

10/715,379

Examiner

Erick Glass

Applicant(s)/Patent under  
Reexamination

SHIGETA ET AL.

Art Unit

2837

**SEARCHED**

Class	Subclass	Date	Examiner
318		11/3/2005	EG
330		11/3/2005	EG

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
noise near2 (absorber or absorbing or decrease or decreasing or reduce or reducing or reduction)	11/3/2005	EG
transistor or semiconductor	11/3/2005	EG
inverter or converter	11/3/2005	EG
dead adj band	11/3/2005	EG